


<b>Search Notes</b>  	<b>Application/Control No.</b>  10540107	<b>Applicant(s)/Patent Under Reexamination</b>  LE BRAS ET AL.
	<b>Examiner</b>  ATIBA O FITZPATRICK	<b>Art Unit</b>  2624

SEARCHED			
Class	Subclass	Date	Examiner
382	128-134	11/12/2009	ATIBA O FITZPATRICK
378	53-56,145-155,193-198	11/12/2009	ATIBA O FITZPATRICK
128	653.1,922	11/12/2009	ATIBA O FITZPATRICK
250	455-465	11/12/2009	ATIBA O FITZPATRICK
356	39-49	11/12/2009	ATIBA O FITZPATRICK
600	407,408,409,410,411,412,413,414,424,425,426	11/12/2009	ATIBA O FITZPATRICK

SEARCH NOTES		
Search Notes	Date	Examiner
East	11/12/2009	ATIBA O FITZPATRICK
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East	11/12/2009	ATIBA O FITZPATRICK
East	11/12/2009	ATIBA O FITZPATRICK
INSPEC	11/12/2009	ATIBA O FITZPATRICK
IEEE Xplore	11/12/2009	ATIBA O FITZPATRICK
Google Scholar	11/12/2009	ATIBA O FITZPATRICK

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<b>INTERFERENCE SEARCH</b>			
<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>

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